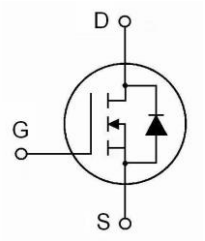
ZH10N80F N-Channel mode Power MOSFET

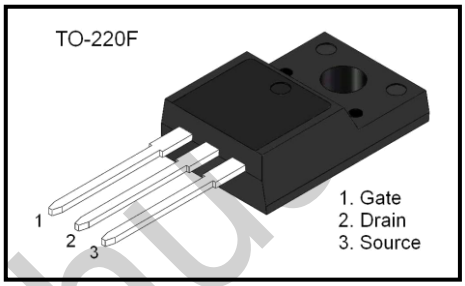
General Description

The ZH10N80F is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristic. This power MOSFET is usually used in high speed switching applications including power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits

Features

- V_{DS} 800V
- I_D 10A
- $R_{DS(ON)}$ (V_{GS} = 10V) <1.1Ω
- Fast Switching Capability
- Avalanche Energy Specified
- Improved dv/dt Capability, High Ruggedness





Absolute Maximum Ratings (T_C = 25℃ unless otherwise specified)

Parameter		Symbol	Ratings	Units
Gate-Drain Voltage		V_{DSS}	800	V
Gate-Source Voltage		V_{GSS}	±30	V
Continuous Drain Current	T_A=25 °C	I_D	10	A
	Pulsed (Note 2)	I_{DM}	40	
Power Dissipation		P_D	36	W
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	920	mJ
	Repetitive (Note 2)	E_{AR}	24	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns
Junction Temperature		T_J	150	℃
Storage Temperature		T_{STG}	-55～155	℃

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature
3. L = 17.3mH, I_{AS} = 10A, V_{DD} = 50V, R_G= 25Ω Starting T_j = 25°C
4. I_{SD} ≤10A, di/dt≤200A/μs, V_{DD}≤BV_{DSS}, Starting T_j = 25°C

Thermal Characteristic

Parameter	Symbol	Value	Units
Maximum Thermal Resistance, Junction-case	$R_{\theta JC}$	3.5	℃/W
Maximum Thermal Resistance, Junction-Ambient	$R_{\theta JA}$	62.5	℃/W

Electrical Characteristics (T_j = 25°C unless otherwise specified)

Parameter		Symbol	Test Conditions	Min.	Typ	Max.	Units
Off Characteristics							
Drain-Source Breakdown Voltage		BV_{DSS}	V_{GS}=0V,I_D=-250μA	800			V
Breakdown Voltage Temperature Coefficient		$\Delta BV_{DSS}/\Delta T_J$	I_D = 250μA, Referenced to 25 °C		0.98		V/°C
Zero Gate Voltage Drain Current		I_{DSS}	V_{DS}= 800V, V_{GS}= 0V			10	μA
Gate Leakage Current	Forward	I_{GSS}	V_{DS}=0V,V_{GS}=30V			100	nA
	Reverse		V_{DS}=0V,V_{GS}=-30V			-100	nA
On Characteristics							
Gate Threshold Voltage		$V_{GS(th)}$	V_{DS}=V_{GS},I_D=-250μA	3.0		5.0	V
Drain-source On-Resistance		$R_{DS(ON)}$	V_{GS} = 10V,I_D = 5A		0.95	1.1	Ω
Dynamic Characteristics							
Input Capacitance		Ciss	V_{DS} = 25V,V_{GS} = 0V, f = 1.0MHz		2150	2800	pF
Output Capacitance		Coss			180	230	
Reverse Transfer Capacitance		Crss			15	24	
Switching Characteristics)							
Turn-On Delay Time		$t_{d(on)}$	V_{DS} = 405V, I_D = 10A R_G = 25Ω (Note1, 2)		50	110	ns
Turn-on Rise Time		t_r			130	270	
Turn-Off elay Time		$t_{d(off)}$			90	190	
Turn-Off Fall		t_f			80	170	
Total Gate Charge		Q_g	V_{DS} = 640V, I_D = 10A V_{GS} = 10V (Note1, 2)		45	58	nC
Gate-Source Charge		Q_{gs}			13.5		
Gate-Drain Charge		Q_{gd}			18		
Drain-Source Diode Characteristics							
Diode Forward Voltage		V_{SD}	V_{GS}=0V, I_S =10A			1.4	V
Diode Forward Current		I_S	-			10	A
Pulsed Diode Forward Current		I_{SM}				40	A
Reverse Recovery Time		t_{rr}	I_S = 10A, V_{GS} = 0V dI_F/dt =100A/μs (Note 1)		730		ns
Reverse Recovery Charge		Q_{rr}			11		nC

Notes: 1. Pulse Test : Pulse width ≤300μs, Duty cycle ≤2%

2. Essentially independent of operating temperature

Test Circuits and Waveforms

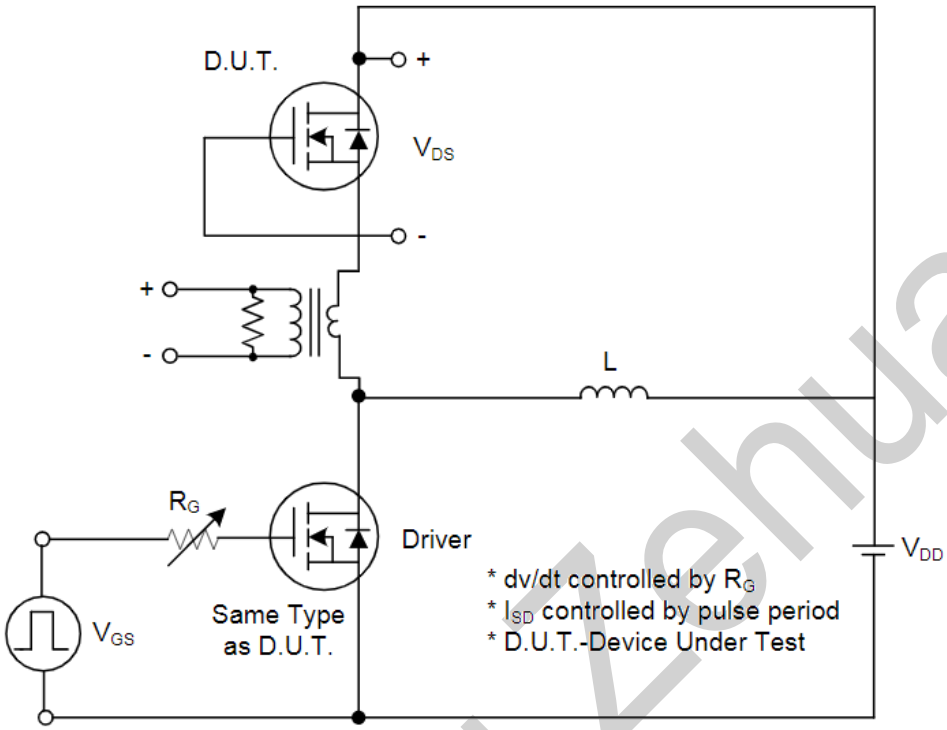


Figure 1. Peak Diode Recovery dv/dt Test Circuit

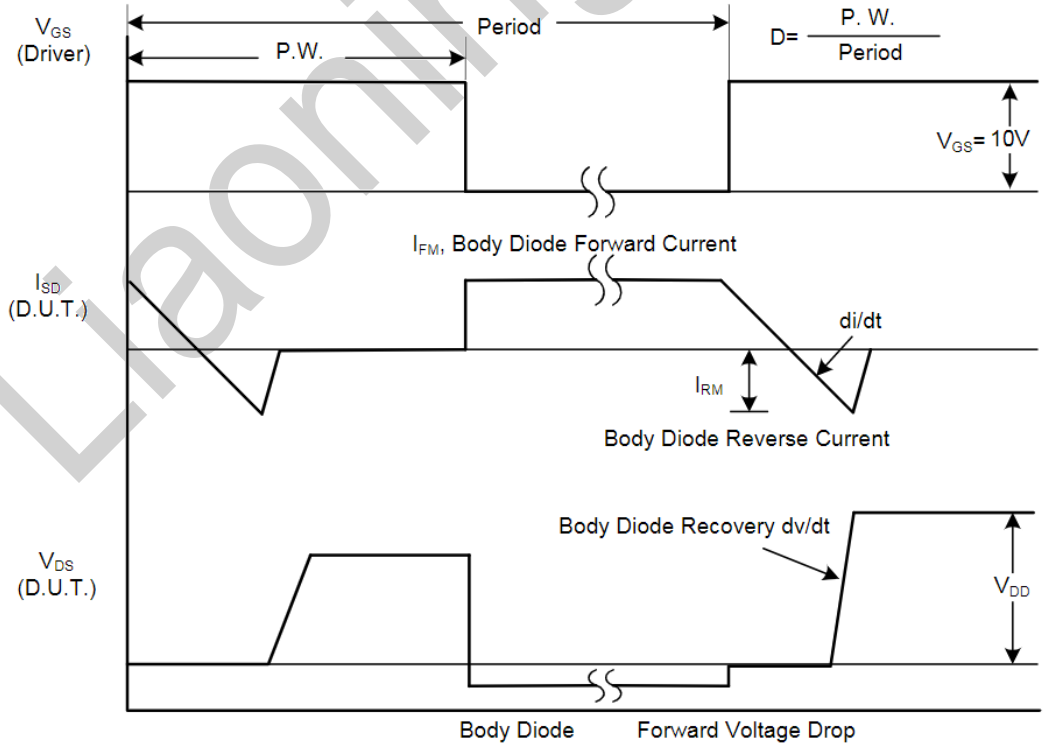


Figure 2. Peak Diode Recovery dv/dt Waveforms

Test Circuits and Waveforms

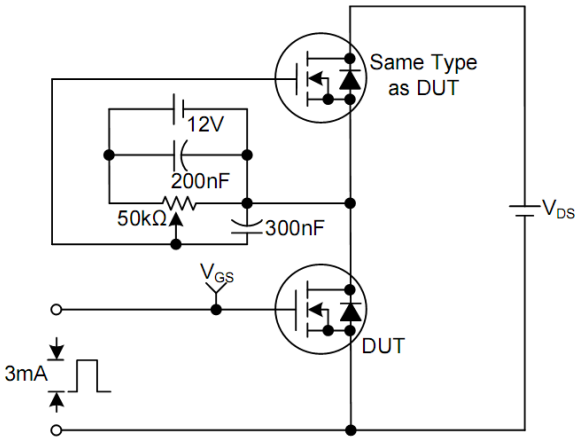


Figure 3. Gate Charge Test Circuit

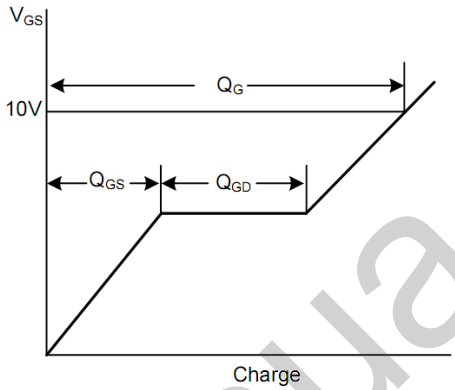


Figure 4. Gate Charge Waveforms

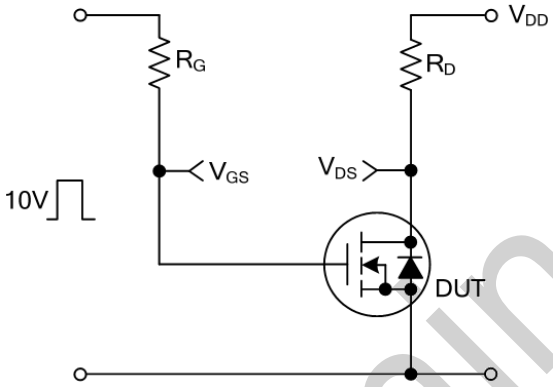


Figure 5. Resistive Switching Circuit

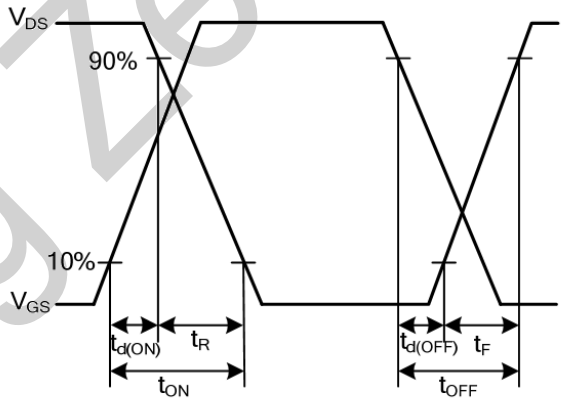


Figure 6. Resistive Switching Waveforms

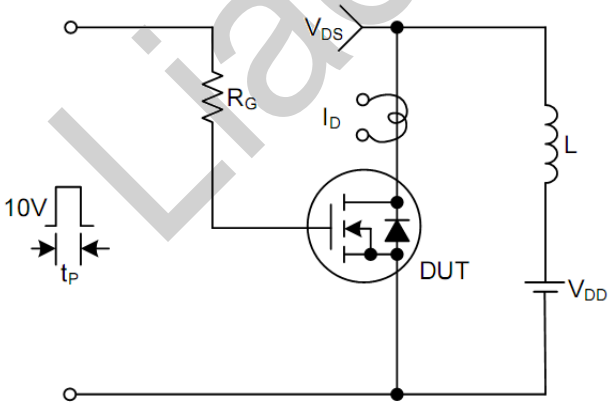


Figure 7. Unclamped Inductive Switching Test Circuit

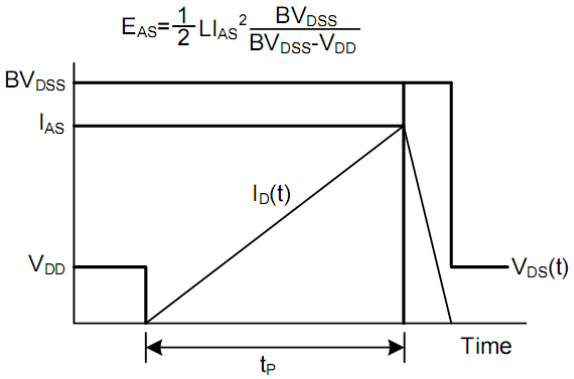


Figure 8. Unclamped Inductive Switching Waveforms

Typical Characteristics

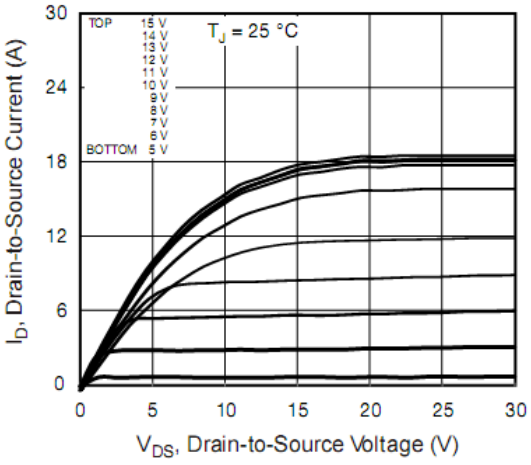


Figure 9. Output Characteristics

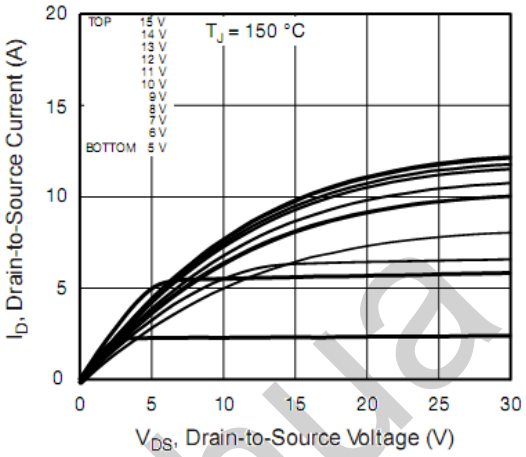


Figure 10. Output Characteristics

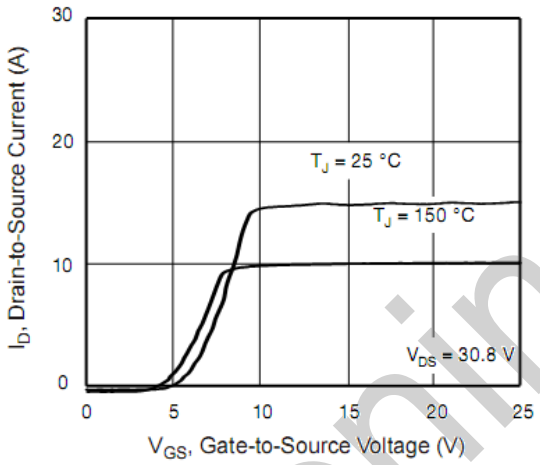


Figure 3. Transfer Characteristics

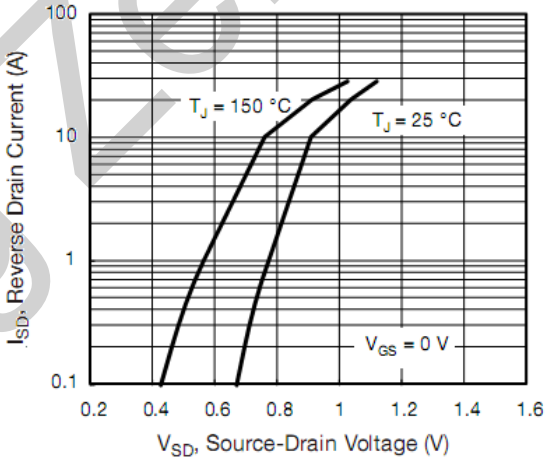


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

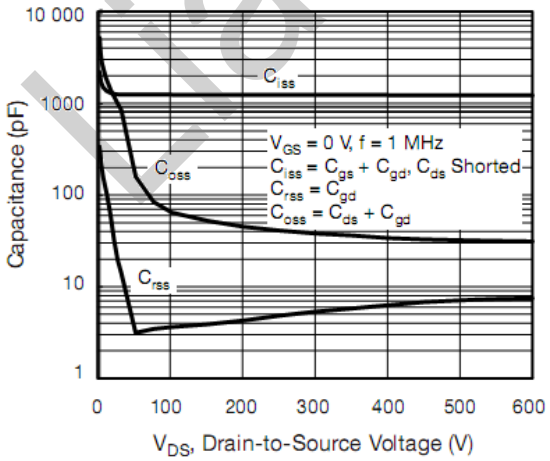


Figure 11. Capacitance Characteristics

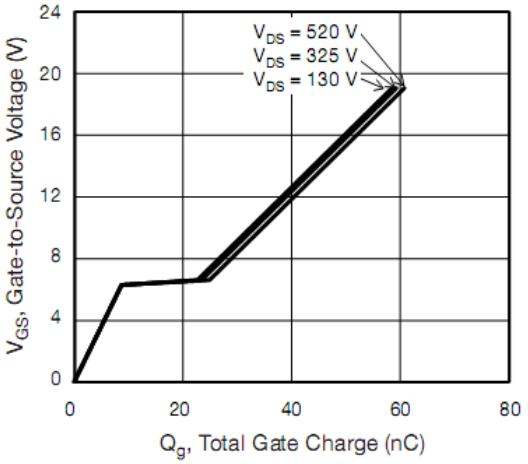


Figure 12. Gate Charge Characteristics

Typical Characteristics

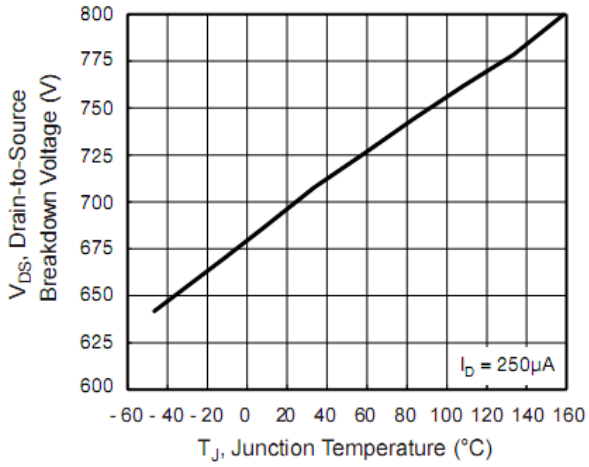


Figure 13. Breakdown Voltage Variation vs Temperature

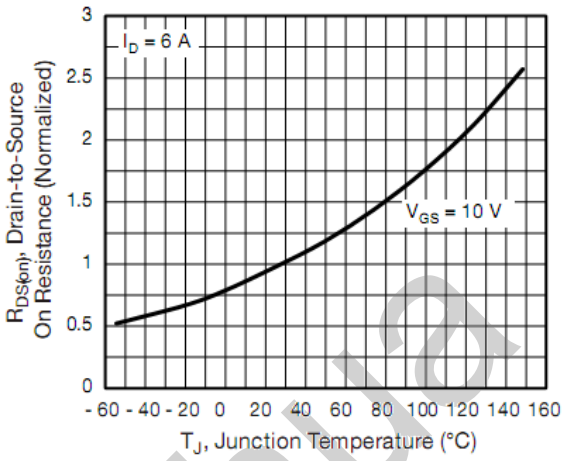


Figure 14. Normalized On-Resistance vs Temperature

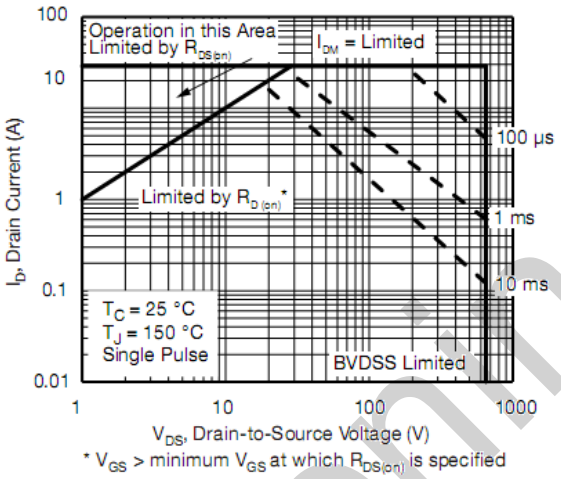


Figure 15. Safe Operating Area

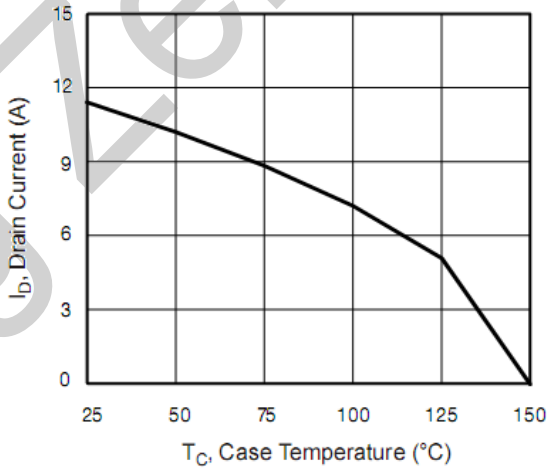


Figure 16. Maximum Drain Current vs Case Temperature

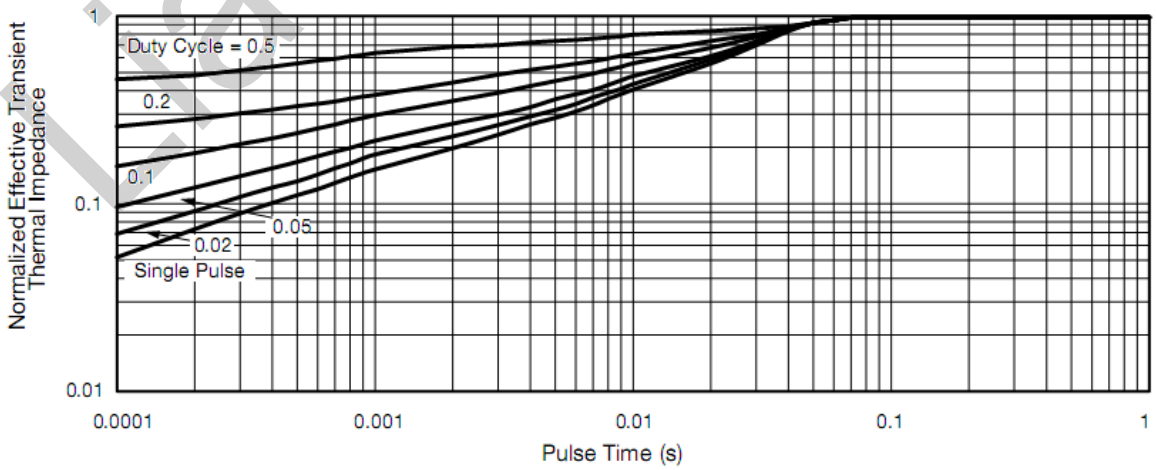
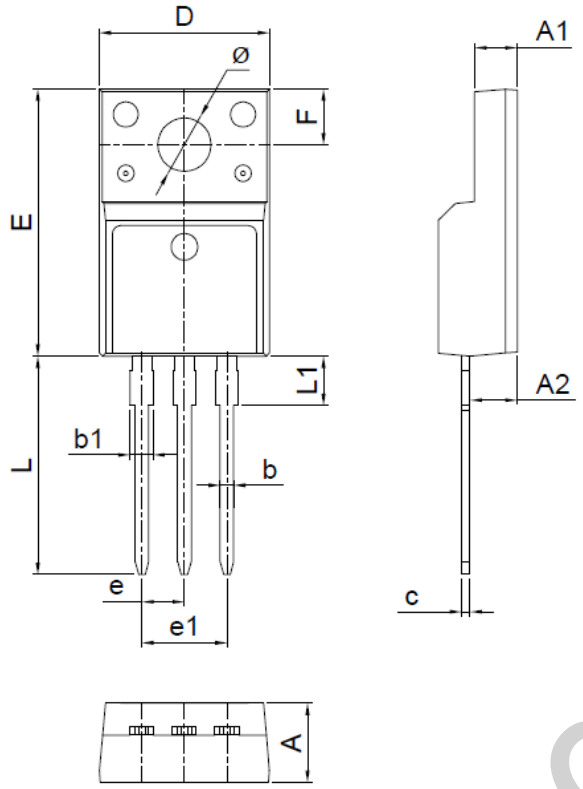


Figure 17. Transient Thermal Response Curve

Package Dimensions



Dim	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	4.50	4.90	0.177	0.193
A1	2.34	2.74	0.092	0.108
A2	2.66	2.86	0.105	0.113
b	0.75	0.85	0.030	0.033
b1	1.24	1.44	0.049	0.057
c	0.40	0.60	0.016	0.024
D	10.00	10.32	0.394	0.406
E	15.75	16.05	0.620	0.632
e	2.44	2.64	0.096	0.104
e1	4.88	5.28	0.192	0.208
F	3.10	3.5	0.122	0.138
L	12.90	13.50	0.508	0.531
L1	2.90	3.30	0.114	0.130
Φ	3.10	3.30	0.122	0.130